



EMC TEST REPORT

Report No.: FCC2012-9480E

Product Name: MID

FCC ID: Q7Q-M1802

Model No. : M1802

Brand Name: **i-mobile**

Applicant: Shenzhen Skyworth Wireless Technology Co., Ltd.

Address: Unit A, Rm 3A01, Skyworth Building, Gaoxin Ave 1S, Nanshan District, Shenzhen, China

Issued by: CCIC-SET

Lab Location: Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055, P. R. China

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Test Report

Product Name: MID

Model No.: M1802

Applicant: Shenzhen Skyworth Wireless Technology Co., Ltd.

Applicant Address: Unit A, Rm 3A01, Skyworth Building, Gaoxin Ave 1S,
Nanshan District, Shenzhen, China

Manufacturer: Shenzhen Skyworth Wireless Technology Co., Ltd.

Manufacturer Address: Skyworth Industrial Park, Tangtou Village, Shiyan Town,
Baoan District, Shenzhen, Guangdong, China

Test Standards: 47 CFR Part 15 Subpart B: Radio Frequency Devices

Test Result: PASS

Tested by:

lulai Jan 10, 2013

Signature, Date

Reviewed by:

Shuangwen Zhang Jan 10, 2013

Signature, Date

Approved by:

Jan 10, 2013

Signature, Date



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| Change History | | |
|----------------|-------------|-------------------|
| Issue | Date | Reason for change |
| 1.0 | Jan 10,2013 | First edition |
| | | |
| | | |

1. GENERAL INFORMATION

1.1 EUT Description

EUT Type : M1802
Serial No..... : (n.a, marked #1 by test site)
FCC ID : Q7Q-M1802
Hardware Version..... : V1.0
Software Version : V1.0
Power Supply : Battery
Brand Name: /
Model No.: WD4070118P
Serial No.: (n.a. marked #1 by test site)
Capacitance: 3600mAh, 13.3Wh
Rated Voltage: 3.7V
Charge Limit: 4.2V
Ancillary Equipment 1 : AC Adapter (Charger for Battery)
Brand Name: /
Model Name: SW-0983
Serial No.: (n.a. marked #1 by test site)
Rated Input: 100-240V, 0.7A, 50/60Hz
Rated Output: = 5V, 2A
Ancillary Equipment 2.....: PC
Brand Name: ThinkPad
Model Name: E420
Serial No.: 1141AH6

Note 1: The EUT is a MID, it supports WIFI (b/g/n model) .

Note 2: The EUT is equipped with a T-Flash card slot; equipped with a USB port which can be connected to the ancillary equipments supplied by the manufacturer e.g. the AC Adapter and the USB Cable.

Note 3: For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

| No. | Identity | Document Title |
|-----|-------------------------------------|-------------------------|
| 1 | 47 CFR Part 15 (10-1-09 Edition) | Radio Frequency Devices |

Test detailed items/section required by FCC rules and results are as below:

| No. | Section | Description | Result |
|-----|---------|--------------------|--------|
| 1 | 15.107 | Conducted Emission | PASS |
| 2 | 15.109 | Radiated Emission | PASS |

NOTE: The EUT has been tested according to 47 CFR Part 15 Subpart B, Class B. The test procedure is according to ANSI C63.4:2009 and CISPR 22:2008. The test results are as following:



1.3 Facilities and Accreditations

1.3.1 Facilities

CNAS-Lab Code: L1659

CCIC-SET Southern Electronic Product Testing (Shenzhen) Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659. A 12.8*6.8*6.4 (m) fully anechoic chamber was used for the radiated spurious emissions test.

FCC-Registration No.: 406086

CCIC-SET Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 406086, Renewal date Nov. 19, 2011, valid time is until Nov. 18, 2014.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

| | |
|-----------------------------|--------------|
| Temperature (°C): | 15°C - 35°C |
| Relative Humidity (%): | 30% -60% |
| Atmospheric Pressure (kPa): | 86KPa-106KPa |

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

| | |
|------------------------------------|--------|
| Uncertainty of Conducted Emission: | ±1.8dB |
| Uncertainty of Radiated Emission: | ±4.8dB |

2. TEST CONDITIONS SETTING

2.1 Test Mode

(1) The first test mode (USB)

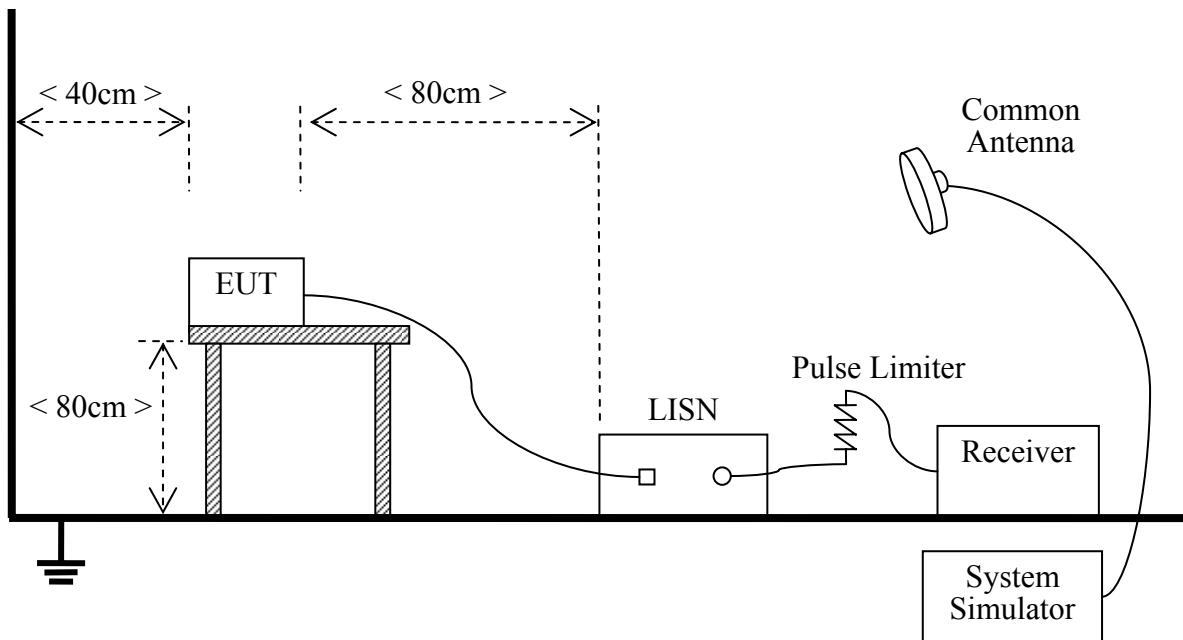
The EUT configuration of the emission tests is TransFlash Card + EUT + Battery + PC.

In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a USB cable supplied by applicant. During the measurement, the data is transmitting between the PC and the TransFlash Card of the EUT.

2.2 Test Setup and Equipments List

2.2.1 Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu\text{H}$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

B. Equipments List:

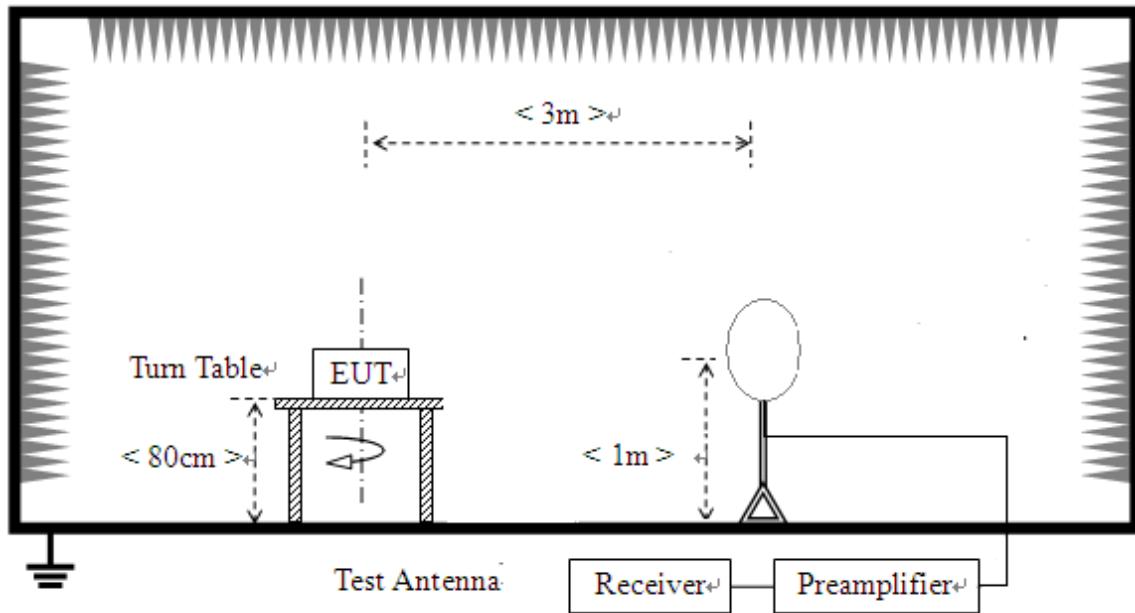
| Description | Manufacturer | Model | Serial No. | Cal. Date |
|------------------|---------------|---------|------------|------------|
| Test Receiver | ROHDE&SCHWARZ | ESCS30 | A0304260 | 2012.06.10 |
| LISN | ROHDE&SCHWARZ | ESH2-Z5 | A0304221 | 2012.06.10 |
| System Simulator | ROHDE&SCHWARZ | CMU200 | A0304212 | 2012.06.10 |

The Cal. Interval was one year.

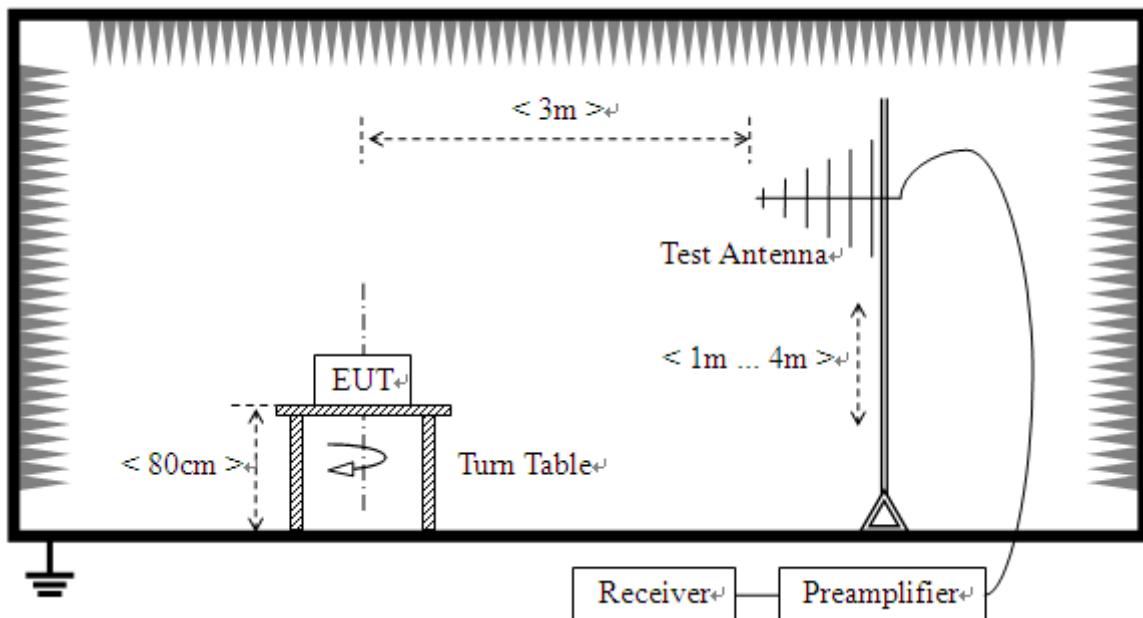
2.2.2 Radiated Emission

A. Test Setup:

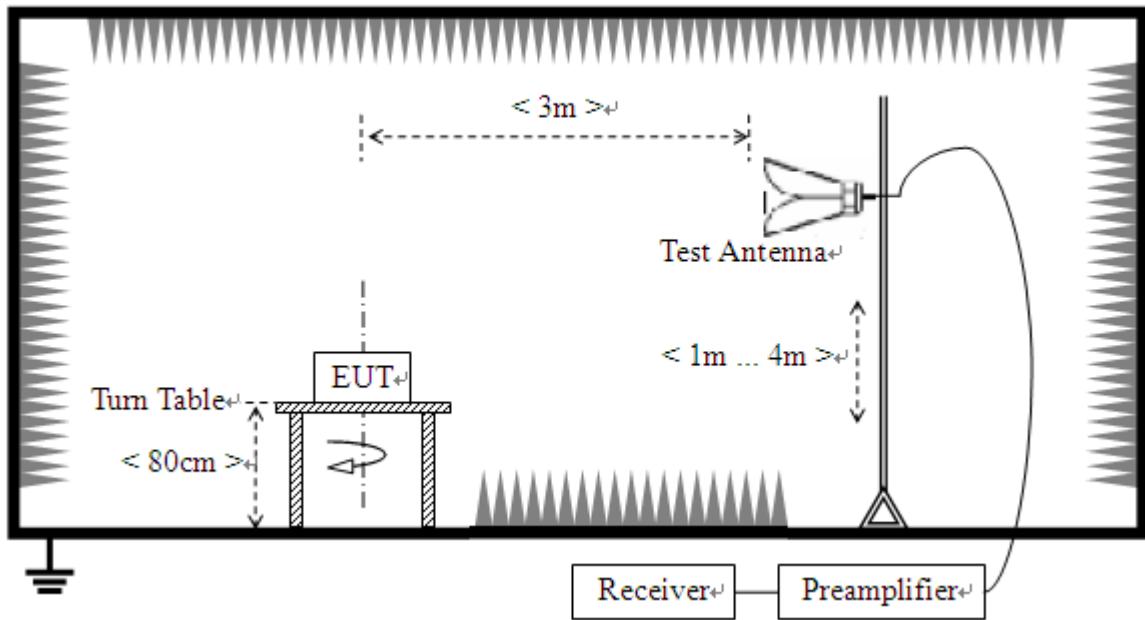
- 1) For radiated emissions from 9kHz to 30MHz



2) For radiated emissions from 30MHz to 1GHz



3) For radiated emissions above 1GHz



B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

- 1) In the frequency range of 9KHz to 30MHz, magnetic field is measured with Loop Test Antenna. The Test Antenna is positioned with its plane vertical at 1m distance from the EUT. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.
- 2) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

| Description | Manufacturer | Model | Serial No. | Cal. Date |
|-----------------------|---------------|----------|------------|------------|
| Test Receiver | ROHDE&SCHWARZ | ESIB7 | A0501375 | 2012.06.10 |
| Test Receiver | ROHDE&SCHWARZ | ESIB26 | A0304218 | 2012.06.10 |
| Semi-Anechoic Chamber | Albatross | 9m*6m*6m | A0412372 | 2012.01.04 |



| Description | Manufacturer | Model | Serial No. | Cal. Date |
|-----------------------|-----------------------------|-----------------------------|------------|------------|
| Test Antenna - Bi-Log | HP | CBL6111A | A9704202 | 2012.06.10 |
| Test Antenna - Horn | ROHDE&SCHWARZ | HF906 | A0304225 | 2012.06.10 |
| System Simulator | ROHDE&SCHWARZ | CMU200 | A0304212 | 2012.06.10 |
| Ampilier 1G~18GHz | ROHDE&SCHWARZ | MITEQ AFS42-0010 1800 | 25-S-42 | 2012.06.10 |
| amplifier 20M~3GHz | Compliance Direction System | PAP-0203H | 22018 | 2012.06.10 |

The Cal. Interval was one year.

3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

| Frequency range (MHz) | Conducted Limit (dB μ V) | |
|-----------------------|------------------------------|----------|
| | Quasi-peak | Average |
| 0.15 - 0.50 | 66 to 56 | 56 to 46 |
| 0.50 - 5 | 56 | 46 |
| 5 - 30 | 60 | 50 |

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

3.1.2 Test Description

See section 2.2.1 of this report.

3.1.3 Test Result

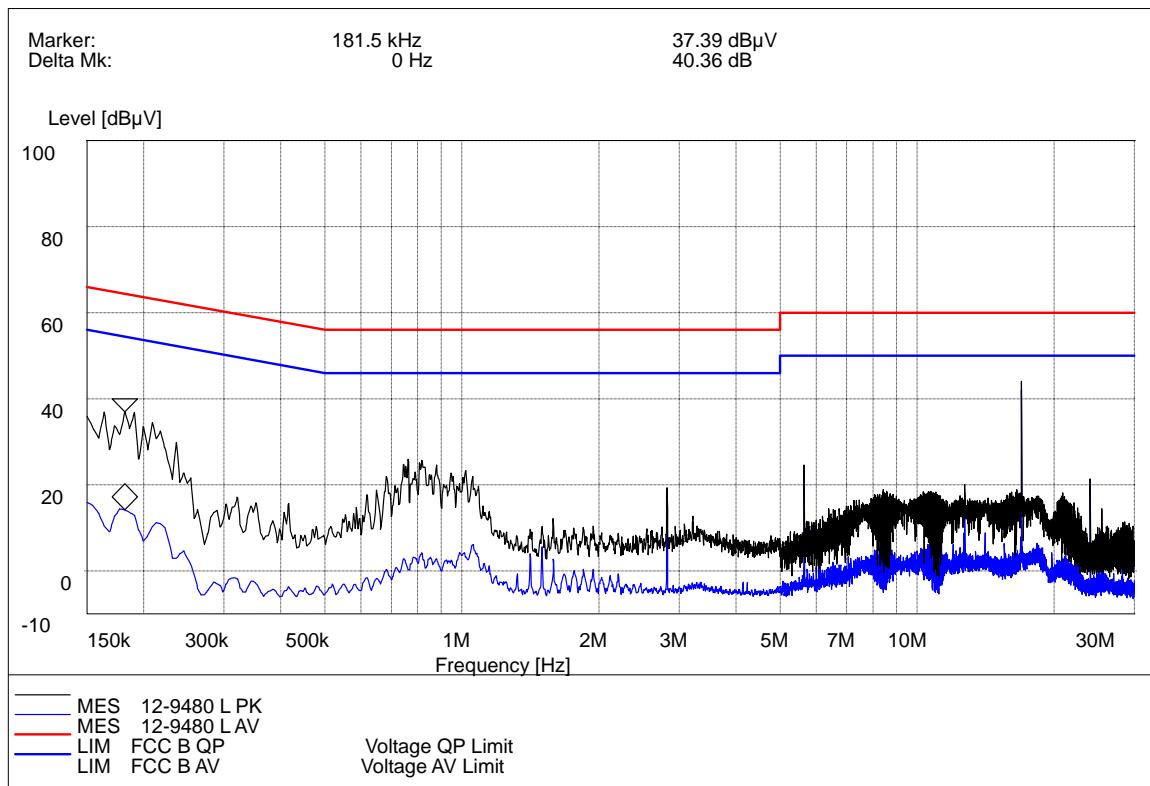
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

3.1.3.1 Test Mode

A. Test Plot and Suspicious Points:

| Conducted Disturbance at Mains Terminals | | | | | | | |
|--|---------------------|---------------------------------|-------------|------------------|---------------------|---------------------------------|-------------|
| L Test Data | | | | | | | |
| QP | | | | AV | | | |
| Frequen cy (MHz) | Limits (dB μ V) | Measurem ent Value (dB μ V) | Margin (dB) | Frequen cy (MHz) | Limits (dB μ V) | Measurem ent Value (dB μ V) | Margin (dB) |
| 0.1815 | 64.4 | 37.39 | 27.01 | 0.1815 | 54.4 | 17.50 | 36.90 |
| 5.6435 | 60 | 23.81 | 36.19 | 5.6435 | 50 | 22.81 | 21.19 |
| 16.934 | 60 | 45.30 | 14.70 | 16.934 | 50 | 44.22 | 5.78 |
| | | | | | | | |

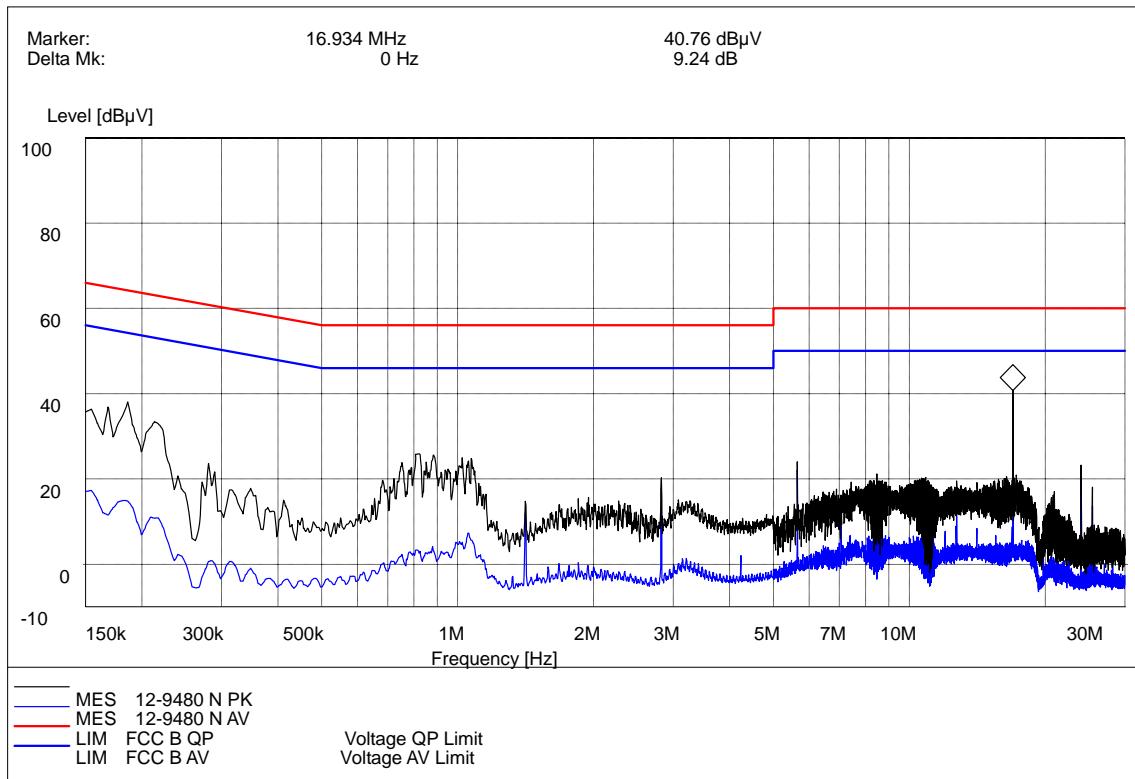
L Test Curve



(Plot A: L Phase)

| Conducted Disturbance at Mains Terminals | | | | | | | |
|--|---------------------|--------------------------------|-------------|-----------------|---------------------|--------------------------------|-------------|
| N Test Data | | | | | | | |
| QP | | | | AV | | | |
| Frequency (MHz) | Limits (dB μ V) | Measurement Value (dB μ V) | Margin (dB) | Frequency (MHz) | Limits (dB μ V) | Measurement Value (dB μ V) | Margin (dB) |
| 0.1870 | 64.20 | 40.10 | 24.10 | 0.1870 | 54.20 | 18.40 | 35.80 |
| 5.6435 | 60 | 23.80 | 36.20 | 5.6435 | 50 | 22.40 | 27.60 |
| 16.934 | 60 | 40.76 | 19.24 | 16.934 | 50 | 39.50 | 10.50 |
| | | | | | | | |

N Test Curve



(Plot B: N Phase)

Test Result: PASS

3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

| Frequency range (MHz) | Field Strength | | Field Strength Limitation at 3m Measurement Dist | |
|-----------------------|----------------|------|--|------------------------|
| | μ V/m | Dist | (uV/m) | (dBuV/m) |
| 0.009 - 0.490 | 2400/F(KHz) | 300m | 10000* 2400/F(KHz) | 20log 2400/F(KHz) + 80 |
| 0.490 - 1.705 | 2400/F(KHz) | 30m | 100* 2400/F(KHz) | 20log 2400/F(KHz) + 40 |
| 1.705 - 30.00 | 30 | 30m | 100*30 | 20log 30 + 40 |
| 30.0 - 88.0 | 100 | 3m | 100 | 20log 100 |
| 88.0 - 216.0 | 150 | 3m | 150 | 20log 150 |
| 216.0 - 960.0 | 200 | 3m | 200 | 20log 200 |
| Above 960.0 | 500 | 3m | 500 | 20log 500 |

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dBuV/m is calculated by 20log Emission Level(uV/m).
- 3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $Ld1 = Ld2 * (d2/d1)^2$.

Example:

F.S Limit at 30m distance is 30uV/m, then F.S Limitation at 3m distance is adjusted as
 $Ld1 = L1 = 30uV/m * (10)^2 = 100 * 30uV/m$.

- 4) The Highest frequency generated or used in the device or on which the device operates or tunes was 1.5GHz, so radiated emissions test frequency from 30MHz to 7.5GHz.

3.2.2 Test Description

See section 0 of this report.

3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels

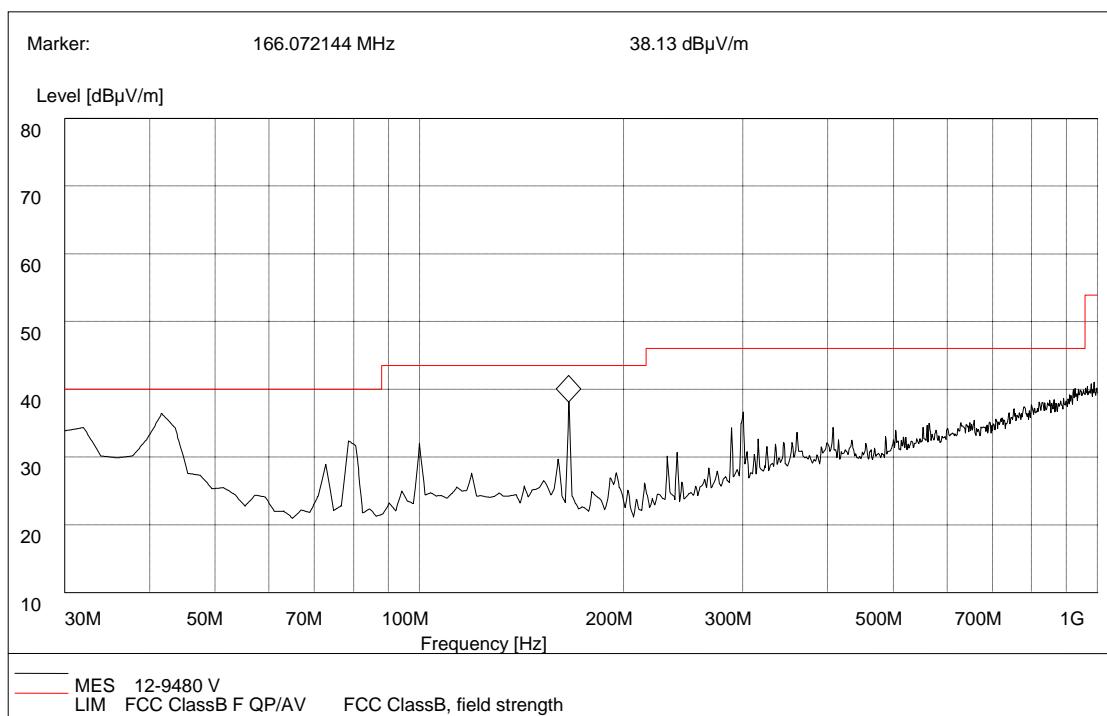
more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

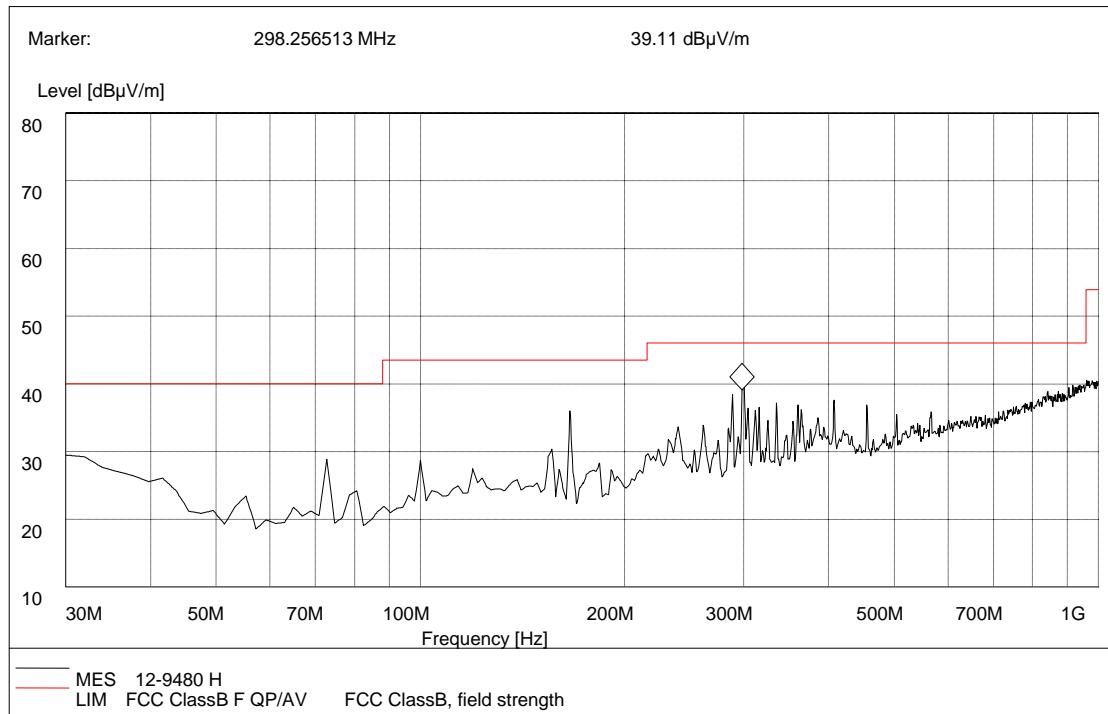
A. Test Plots and Suspicious Points:

NOTE: The emissions are too small to be measured and are at least 6 dB below the limit, So all the data of marked are pass.



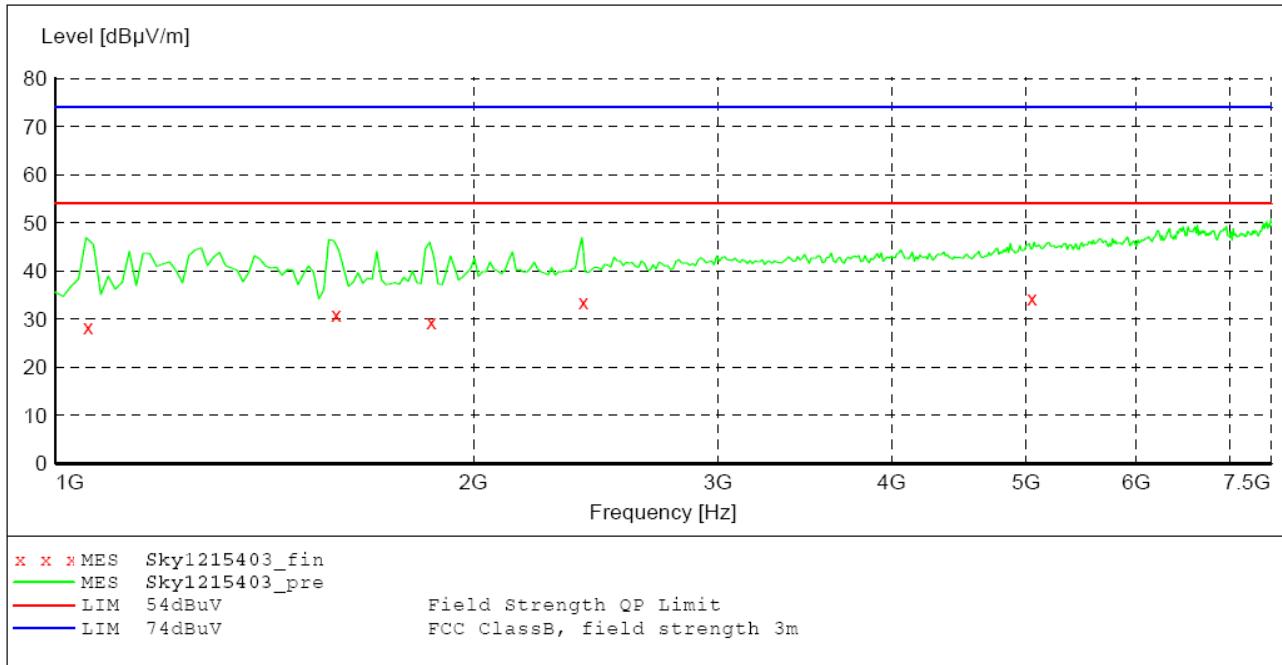
(Plot A: Test Antenna Vertical 30M - 1G)

| Frequency (MHz) | QuasiPeak (dB μ V/m) | Bandwidth (kHz) | Antenna height (cm) | Limit (dB μ V/m) | Margin (dB) | Antenna | Verdict |
|-----------------|--------------------------|-----------------|---------------------|----------------------|-------------|----------|---------|
| 42.2432568 | 36.76 | 120.000 | 100.0 | 40.00 | 3.24 | Vertical | Pass |
| 166.072144 | 38.13 | 120.000 | 100.0 | 43.52 | 5.39 | Vertical | Pass |
| 300.042323 | 37.34 | 120.000 | 100.0 | 46.02 | 8.68 | Vertical | Pass |



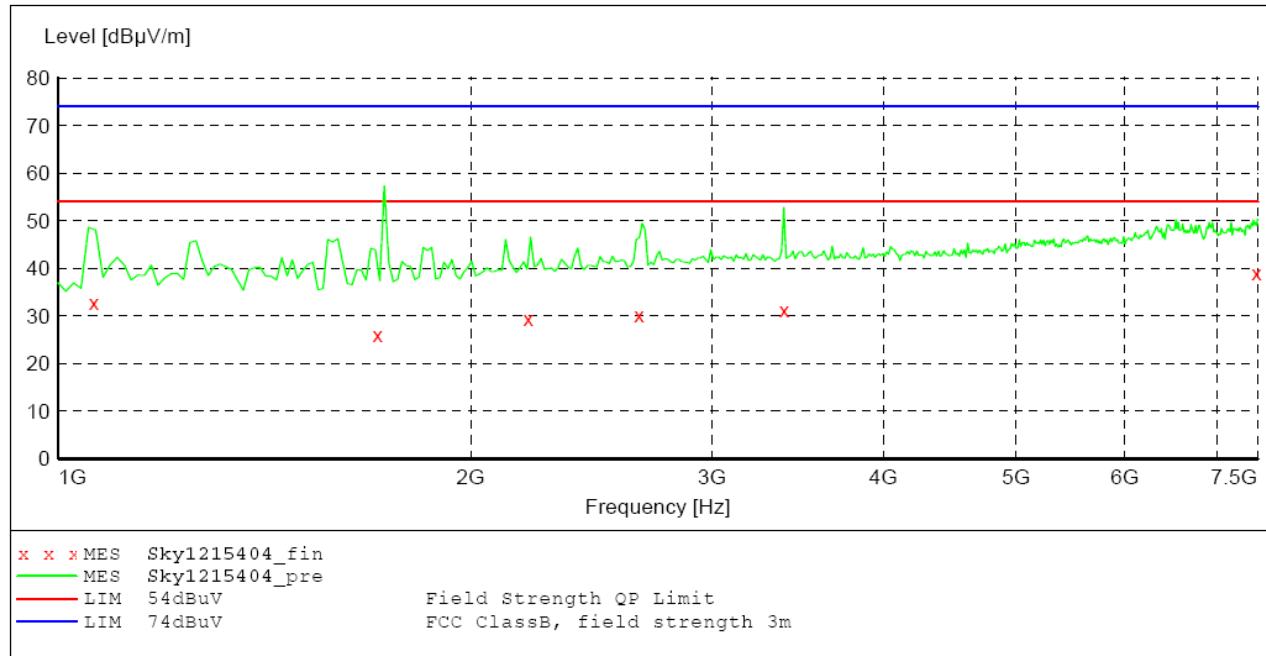
(Plot B: Test Antenna Horizontal 30M - 1G)

| Frequency (MHz) | QuasiPeak (dB μ V/m) | Bandwidth (kHz) | Antenna height (cm) | Limit (dB μ V/m) | Margin (dB) | Antenna | Verdict |
|-----------------|--------------------------|-----------------|---------------------|----------------------|-------------|------------|---------|
| 73.564892 | 28.64 | 120.000 | 100.0 | 40.00 | 11.36 | Horizontal | Pass |
| 172.456821 | 36.87 | 120.000 | 100.0 | 43.52 | 6.65 | Horizontal | Pass |
| 298.256513 | 39.11 | 120.000 | 100.0 | 46.02 | 6.91 | Horizontal | Pass |
| | | | | | | | |



(Plot C: Test Antenna Horizontal 1G – 7.5G)

| Frequency (MHz) | AV (dB μ V/m) | Bandwidth (kHz) | Antenna height (cm) | Limit (dB μ V/m) | Margin (dB) | Antenna | Verdict |
|-----------------|-------------------|-----------------|---------------------|----------------------|-------------|------------|---------|
| 1056.00000 | 28.40 | 1000.000 | 100.0 | 54.00 | 25.60 | Horizontal | Pass |
| 1592.50000 | 30.90 | 1000.000 | 150.0 | 54.00 | 23.10 | Horizontal | Pass |
| 1865.00000 | 29.50 | 1000.000 | 100.0 | 54.00 | 24.50 | Horizontal | Pass |
| 2400.00000 | 33.50 | 1000.000 | 100.0 | 54.00 | 20.50 | Horizontal | Pass |
| 5049.50000 | 34.30 | 1000.000 | 150.0 | 54.00 | 19.70 | Horizontal | Pass |
| 7505.00000 | 39.10 | 1000.000 | 100.0 | 54.00 | 14.90 | Horizontal | Pass |
| | | | | | | | |



(Plot D: Test Antenna Vertical 1G – 7.5G)

| Frequency (MHz) | AV (dB μ V/m) | Bandwidth (kHz) | Antenna height (cm) | Limit (dB μ V/m) | Margin (dB) | Antenna | Verdict |
|-----------------|-------------------|-----------------|---------------------|----------------------|-------------|----------|---------|
| 1062.00000 | 32.90 | 1000.000 | 150.0 | 54.00 | 21.10 | Vertical | Pass |
| 1711.00000 | 26.10 | 1000.000 | 150.0 | 54.00 | 27.90 | Vertical | Pass |
| 2203.00000 | 29.40 | 1000.000 | 123.0 | 54.00 | 24.60 | Vertical | Pass |
| 2654.00000 | 30.20 | 1000.000 | 148.0 | 54.00 | 23.80 | Vertical | Pass |
| 3386.00000 | 31.20 | 1000.000 | 150.0 | 54.00 | 22.80 | Vertical | Pass |
| 7490.50000 | 38.90 | 1000.000 | 100.0 | 54.00 | 15.10 | Vertical | Pass |
| | | | | | | | |

Test Result: PASS

** END OF REPORT **